

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE


[Membership](#) [Publications/Services](#) [Standards](#) [Conferences](#) [Careers/Jobs](#)
IEEE Xplore
RELEASE 1.0

 Welcome
 United States Patent and Trademark Office


» See

[Help](#) [FAQ](#) [Terms](#) [IEEE Peer Review](#)
[Quick Links](#)
Welcome to IEEE Xplore

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

 Your search matched **4** of **1015452** documents.

 A maximum of **500** results are displayed, **15** to a page, sorted by **Relevance Descending** order.

Refine This Search:

You may refine your search by editing the current search expression or enter a new one in the text box.

(watermark* or hid* or embed* or steganograph*) <para

☐ Check to search within this result set

Results Key:
JNL = Journal or Magazine **CNF** = Conference **STD** = Standard

1 A general family of multivariable digital lattice filters
Vaidyanathan, P.; Mitra, S.;

 Circuits and Systems, IEEE Transactions on , Volume: 32 , Issue: 12 , Dec 19
 Pages:1234 - 1245

[\[Abstract\]](#) [\[PDF Full-Text \(1240 KB\)\]](#) **IEEE JNL**
2 Association and content-based retrieval
Djeraba, C.;

 Knowledge and Data Engineering, IEEE Transactions on , Volume: 15 , Issue:
 1 , Jan.-Feb. 2003
 Pages:118 - 135

[\[Abstract\]](#) [\[PDF Full-Text \(6991 KB\)\]](#) **IEEE JNL**
3 Object localization in 2D images based on Kohonen's self-organizational feature maps
Yuan, C.; Niemann, H.;

 Neural Networks, 1999. IJCNN '99. International Joint Conference on , Volum
 5 , 10-16 July 1999
 Pages:3134 - 3137 vol.5

[\[Abstract\]](#) [\[PDF Full-Text \(376 KB\)\]](#) **IEEE CNF**
4 Analysis of real-time embedded systems for co-design
Benders, L.P.M.;

 Rapid System Prototyping, 1995. Proceedings., Sixth IEEE International Work
 on , 7-9 June 1995
 Pages:26 - 32

[\[Abstract\]](#) [\[PDF Full-Text \(592 KB\)\]](#) **IEEE CNF**

[Home](#) | [Log out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#) |
[New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2004 IEEE — All rights reserved